Dual Boost Power Module

Product Preview

NXH80B120MNQ0SNG

The NXH80B120MNQ0SNG is a power module containing a dual boost stage. The integrated SiC MOSFETs and SiC Diodes provide lower conduction losses and switching losses, enabling designers to achieve high efficiency and superior reliability.

Features

- 1200 V 80 mΩ SiC MOSFETs
- Low Reverse Recovery and Fast Switching SiC Diodes
- 1600 V Bypass and Anti-parallel Diodes
- Low Inductive Layout
- Solderable Pins
- Thermistor
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- Solar Inverters
- Uninterruptable Power Supplies

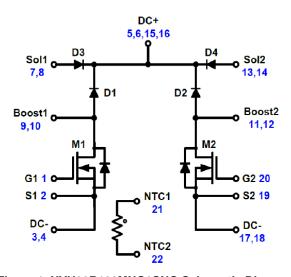
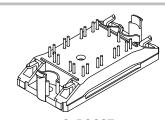


Figure 1. NXH80B120MNQ0SNG Schematic Diagram



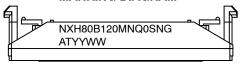
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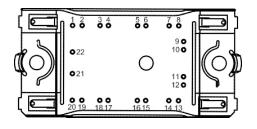
Q0BOOST CASE 180AJ SOLDER PINS

MARKING DIAGRAM



G = Pb-Free Package
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 4 of this data sheet.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

ABSOLUTE MAXIMUM RATINGS (Note 1) $T_J = 25$ °C unless otherwise noted

Symbol	Value	Unit
		-
V _{DS}	1200	V
V _{GS}	-15/+25	V
I _D	23	А
I _{D(Pulse)}	69	Α
P _{tot}	69	W
T_{JMIN}	-40	°C
T _{JMAX}	175	°C
•		•
V_{RRM}	1200	V
I _F	31	А
I _{FSM}	93	Α
P _{tot}	97	W
l ² t	19	A ² s
T _{JMIN}	-40	°C
T_JMAX	175	°C
V_{RRM}	1600	V
I _F	44	А
I _{FRM}	132	А
P _{tot}	63	W
T _{JMIN}	-40	°C
T_{JMAX}	150	°C
T _{stg}	-40 to 125	°C
•		•
V _{is}	3000	V _{RMS}
	12.7	mm
	VDS VGS ID ID(Pulse) Ptot TJMIN TJMAX VRRM IF IFSM Ptot I²t TJMIN TJMAX VRRM IF IFSM Ptot I²t TJMIN TJMAX VRRM IF IFSM TJMAX TJMAX	VDS 1200 VGS -15/+25 ID 23 ID(Pulse) 69 Ptot 69 TJMIN -40 TJMAX 175 VRRM 1200 IF 31 IFSM 93 Ptot 97 I²t 19 TJMIN -40 TJMAX 175 VRRM 1600 IF 44 IFRM 132 Ptot 63 TJMIN -40 TJMAX 150 Tstg -40 to 125

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

RECOMMENDED OPERATING RANGES

Parameter	Symbol	Min	Max	Unit
Module Operating Junction Temperature	TJ	-40	(T _{JMAX} – 25)	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Refer to <u>ELECTRICAL CHARACTERISTICS</u>, <u>RECOMMENDED OPERATING RANGES</u> and/or APPLICATION INFORMATION for Safe Operating parameters.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Characteristic	Test Conditions	Symbol	Min	Тур	Max	Unit
BOOST MOSFET CHARACTERIST	ics					
Zero Gate Voltage Drain Current	V _{GS} = 0 V, V _{DS} = 1200 V, T _J = 25°C	I _{DSS}	-	-	100	μΑ
Static Drain-to-Source On	V _{GS} = 20 V, I _D = 20 A, T _J = 25°C	R _{DS(on)}	-	80	110	mΩ
Resistance	V _{GS} = 20 V, I _D = 20 A, T _J = 150°C	1	_	114	162	1
Gate-Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 5$ mA	V _{GS(th)}	1.8	2.0	4.3	٧
Gate-Source Leakage Current	V _{GS} = 25 V, V _{DS} = 0 V	I _{GSS}	_	-	1	μА
Turn-on Delay Time	T _J = 25°C	t _{d(on)}	-	13.4	=	ns
Rise Time	V_{DS} = 700 V, V_{GS} = 20 V, -5 V I_{D} = 30 A, R_{G} = 4.7 Ω	t _r	_	3.6	_	1
Turn-off Delay Time	- 10 - 00 A, Fig - 4.7 sz	t _{d(off)}	-	27.6	_	1
Fall Time	1	t _f	_	10.3	_	1
Turn-on Switching Loss per Pulse		E _{on}	-	166	-	μJ
Turn-off Switching Loss per Pulse		E _{off}	-	49.2	-	
Turn-on Delay Time	T _J = 125°C	t _{d(on)}	-	13.7	_	ns
Rise Time	V_{DS} = 700 V, V_{GS} = 20 V, -5 V I_{D} = 30 A, R_{G} = 4.7 Ω	t _r	-	3.5	-	1
Turn-off Delay Time	10 - 30 71, 11g - 4.7 12	t _{d(off)}	_	29.56	_	1
Fall Time	1	t _f	-	10.36	-	1
Turn-on Switching Loss per Pulse		E _{on}	-	154	-	μJ
Turn-off Switching Loss per Pulse		E _{off}	_	46.65	_	1
Input Capacitance	V _{DS} = 800 V, V _{GS} = 0 V, f = 1 MHz	C _{iss}	-	1038.7	-	pF
Output Capacitance		C _{oss}	_	95.5	_	
Reverse Transfer Capacitance		C _{rss}	_	10.9	_	
Total Gate Charge	V _{DS} = 600 V, I _D = 20 A, V _{GS} = 20 V, -5 V	Q_g	_	74.72	_	nC
Thermal Resistance - chip-to-case	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJC}	-	1.37	-	K/W
Thermal Resistance – chip-to- heatsink	$\lambda = 2.9 \text{ W/mK}$	R _{thJH}	_	1.94	_	K/W
BOOST DIODE CHARACTERISTIC	s					
Diode Reverse Leakage Current	V _R = 1200 V	I _R		_	300	μΑ
Diode Forward Voltage	I _F = 20 A, T _J = 25°C	V_{F}		1.49	1.7	V
	$I_F = 20 \text{ A}, T_J = 150^{\circ}\text{C}$		ı	2.17	ı	
Reverse Recovery Time	T _J = 25°C	t _{rr}	1	12	1	ns
Reverse Recovery Charge	V_{DS} = 700 V, V_{GS} = 20 V, -5 V I_{D} = 30 A, R_{G} = 4.7 Ω	Q _{rr}	-	159	-	nC
Peak Reverse Recovery Current]	I _{RRM}	T	21.2	_	Α
Peak Rate of Fall of Recovery Current		di/dt	-	7240	ı	A/μs
Reverse Recovery Energy		E _{rr}	I	70	_	μJ
Reverse Recovery Time	T _J = 125°C	t _{rr}	-	11.7	_	ns
Reverse Recovery Charge	$V_{DS} = 700 \text{ V}, V_{GS} = 20 \text{ V}, -5 \text{ V}$	Q _{rr}	=	153	=	nC
Peak Reverse Recovery Current	$I_D = 30 \text{ A}, R_G = 4.7 \Omega$	I _{RRM}	=	23.8	=	Α
Peak Rate of Fall of Recovery Current	1	di/dt	_	8068	_	A/μs
Reverse Recovery Energy	1	E _{rr}	_	66.3	_	μJ

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified) (continued)

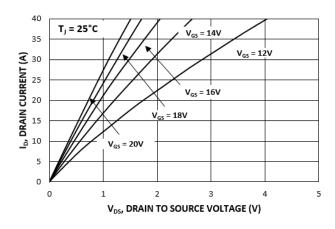
Characteristic Test Conditions		Symbol	Min	Тур	Max	Unit
BOOST DIODE CHARACTERISTIC	S					•
Thermal Resistance - chip-to-case	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJC}	-	0.98	_	K/W
Thermal Resistance – chip-to-heatsink	$\lambda = 2.9 \text{ W/mK}$	R _{thJH}	-	1.33	_	K/W
BYPASS DIODE CHARACTERISTI	cs	<u>.</u>				
Diode Reverse Leakage Current	V _R = 1600 V, T _J = 25°C	I _R	_	_	100	μΑ
Diode Forward Voltage	I _F = 30 A, T _J = 25°C	V _F	-	1.04	1.4	V
	I _F = 30 A, T _J = 150°C		-	0.94	-	1
Thermal Resistance - chip-to-case	Thermal grease, Thickness = 2.1 Mil ±2%	R _{thJC}	-	1.12	_	K/W
Thermal Resistance – chip-to-heatsink	$\lambda = 2.9 \text{ W/mK}$	R _{thJH}	=	1.56	=	K/W
THERMISTOR CHARACTERISTICS	3					
Nominal resistance		R ₂₅	-	22	-	kΩ
Nominal resistance	T = 100°C	R ₁₀₀	-	1486	_	Ω
Deviation of R25		ΔR/R	-5	-	5	%
Power dissipation		P _D	-	200	_	mW
Power dissipation constant			-	2	_	mW/K
B-value	B(25/50), tolerance ±3%		-	3950	_	K
B-value	B(25/100), tolerance ±3%		_	3998	_	K

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

ORDERING INFORMATION

Part Number	Marking	Package	Shipping
NXH80B120MNQ0SNG	NXH80B120MNQ0SNG	Q0BOOST - Case 180AJ (Pb-Free and Halide-Free Solder Pins)	24 Units / Blister Tray

TYPICAL CHARACTERISTICS - MOSFET, BOOST DIODE AND BYPASS DIODE



T_J = 175°C

35

V_{GS} = 12V

V_{GS} = 14V

V_{GS} = 16V

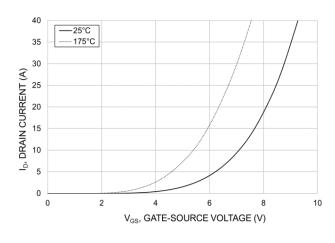
V_{GS} = 18V

V_{GS} = 18V

V_{DS}, DRAIN TO SOURCE VOLTAGE (V)

Figure 2. MOSFET On Region Characteristics

Figure 3. MOSFET On Region Characteristics



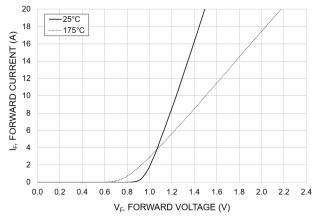


Figure 4. MOSFET Transfer Characteristics

Figure 5. Boost Diode Forward Characteristics

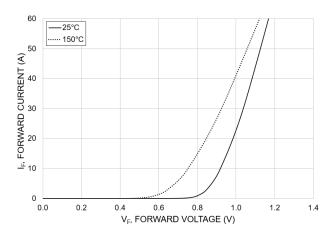
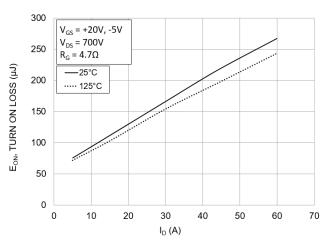


Figure 6. Bypass Diode Forward Characteristics

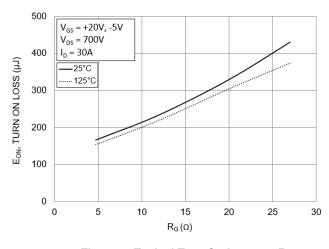
TYPICAL SWITCHING CHARACTERISTICS - MOSFET



160 $V_{GS} = +20V, -5V$ $V_{DS} = 700V$ 140 $R_G = 4.7\Omega$ EoFF, TURN OFF LOSS (µJ) 120 -25°C 125°C 100 80 60 40 20 0 10 20 30 40 50 60 $I_D(A)$

Figure 7. Typical Turn On Loss vs. ID

Figure 8. Typical Turn Off Loss vs. ID



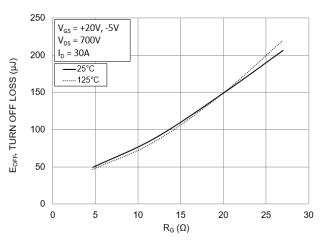
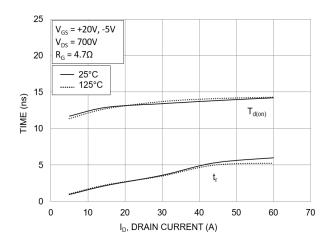


Figure 9. Typical Turn On Loss vs. R_G

Figure 10. Typical Turn Off Loss vs. R_G



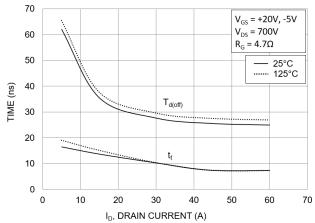
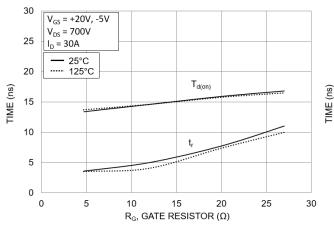


Figure 11. Typical Turn On Switching Time vs. ID

Figure 12. Typical Turn Off Switching Time vs. ID

TYPICAL CHARACTERISTICS - MOSFET

80

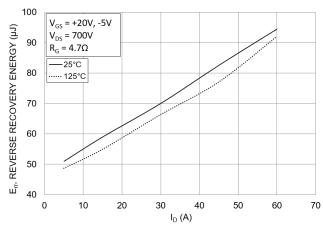


 $V_{GS} = +20V, -5V$ V_{DS} = 700V 70 I_D = 30A 60 - 25°C 125°C 50 40 30 20 10 0 15 25 30 0 R_G , GATE RESISTOR (Ω)

Figure 13. Typical Turn On Switching Time vs. R_G

Figure 14. Typical Turn Off Switching Time vs. $R_{\mbox{\scriptsize G}}$

TYPICAL CHARACTERISTICS - BOOST DIODE



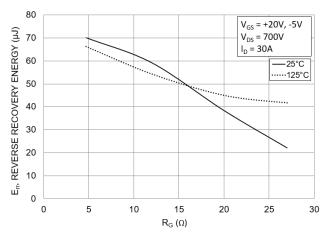
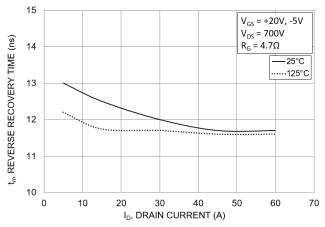


Figure 15. Typical Reverse Recovery Energy Loss vs. I_D

Figure 16. Typical Reverse Recovery Energy Loss vs. R_G



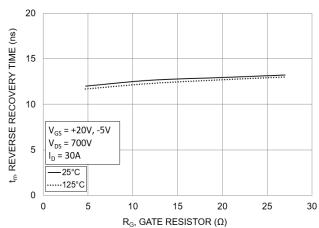
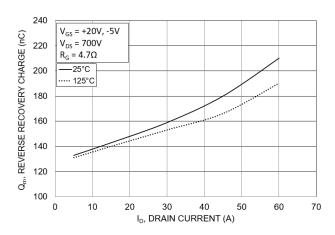


Figure 17. Typical Reverse Recovery Time vs. I_D

Figure 18. Typical Reverse Recovery Time vs. R_G

TYPICAL SWITCHING CHARACTERISTICS - BOOST DIODE



170 REVERSE RECOVERY CHARGE (nC) 160 150 140 130 V_{GS} = +20V, -5V 120 V_{DS} = 700V $I_{D} = 30A$ 110 -25°C ď ·· 125°C 100 0 15 20 25 30 R_G , GATE RESISTOR (Ω)

Figure 19. Typical Reverse Recovery Charge vs. ID

30 $V_{GS} = +20V, -5V$ I_{Im}, REVERSE RECOVERY CURRENT (A) $V_{DS} = 700V$ 28 $R_G = 4.7\Omega$ −25°C 26 ····· 125°C 24 22 20 18 16 0 10 40 50 60 70 I_D, DRAIN CURRENT (A)

Figure 20. Typical Reverse Recovery Charge vs. R_G

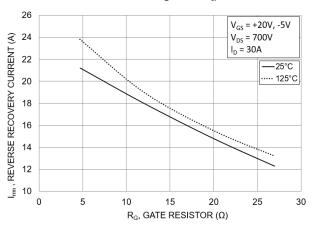


Figure 21. Typical Reverse Recovery Peak Current vs. I_D

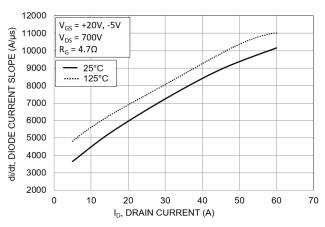


Figure 22. Typical Reverse Recovery Peak Current vs. R_G

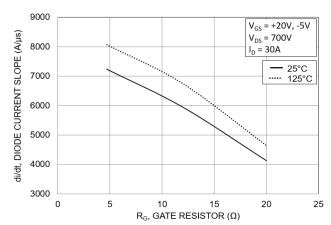


Figure 23. Typical di/dt vs. ID

Figure 24. Typical di/dt vs. R_G

TRANSIENT THERMAL IMPEDANCE - MOSFET, BOOST DIODE AND BYPASS DIODE

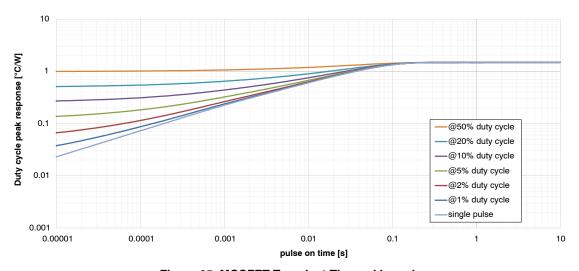


Figure 25. MOSFET Transient Thermal Impedance

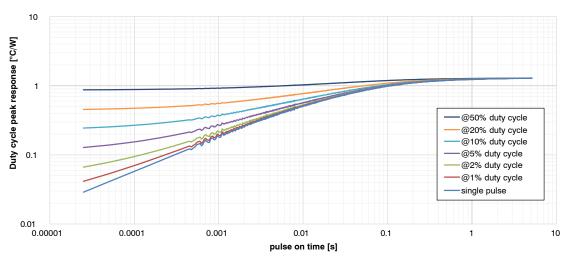


Figure 26. Boost Diode Transient Thermal Impedance

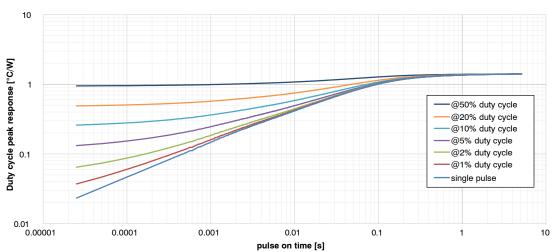


Figure 27. Bypass Diode Transient Thermal Impedance

GATE CHARGE, CAPACITANCE CHARGE, SOA AND THERMISTOR CHARACTERISTICS

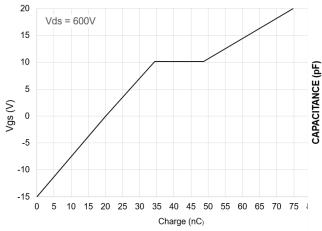


Figure 28. Gate Voltage vs. Gate Charge

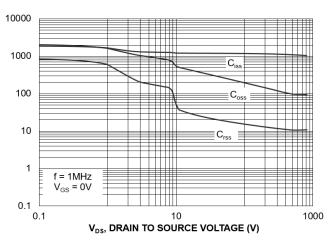


Figure 29. Capacitance Charge

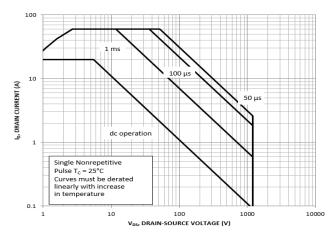


Figure 30. FBSOA

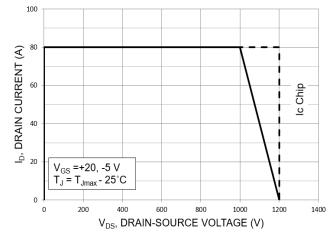


Figure 31. RBSOA

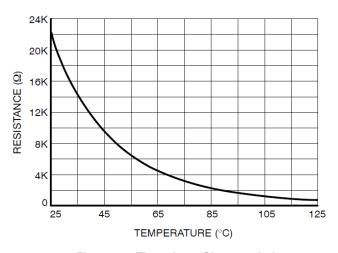
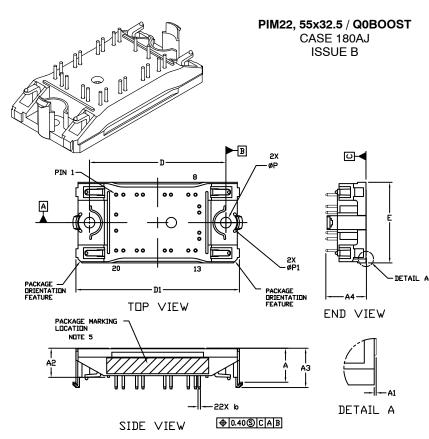


Figure 32. Thermistor Characteristics



DATE 08 NOV 2017

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSION 6 APPLIES TO THE PLATED TERMINALS AND IS MEASURED BETWEEN 1.00 AND 3.00 FROM THE TERMINAL TIP.
- 4. POSITION OF THE CENTER OF THE TERMINALS
 IS DETERMINED FROM DATUM B THE CENTER OF
 DIMENSION D, X DIRECTION, AND FROM DATUM A,
 Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED
 IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH
 DIRECTIONS.
- PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

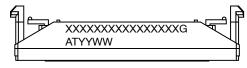
	MILLIMETERS			
DIM	MIN.	NDM.		
A	13.50	13.90		
A1	0.10	0.30		
A2	11.50	11.90		
A3	15.65	16.05		
A4	16.35 REF			
۵	0.95	1.05		
D	54.80	55.20		
D1	65.60	66.20		
E	32.20	32.80		
Ք	4.20	4.40		
P1	8.90	9.10		

MOUNTING HOLE POSITION

NOTE 4

	HOLE P	OSITION		PIN PE	NDITIZE	PIN POSITION			PIN PI	NDITIZE	
PIN	Х	Y	PIN	Х	Υ	PIN	Х	Y	PIN	Х	Υ
1	-16.75	-11.25	12	16.75	6.55	1	-16.75	11.25	12	16.75	-6.55
2	-13.85	-11.25	13	15.25	11.25	2	-13.85	11.25	13	15.25	-11.25
3	-8.45	-11.25	14	12.35	11.25	3	-8.45	11.25	14	12.35	-11.25
4	-5.95	-11.25	15	5.35	11.25	4	-5.95	11.25	15	5.35	-11.25
5	2.85	-11.25	16	2.85	11.25	5	2.85	11.25	16	2.85	-11.25
6	5.35	-11.25	17	-5.95	11.25	6	5.35	11.25	17	-5.95	-11.25
7	12.35	-11.25	18	-8.45	11.25	7	12.35	11.25	18	-8.45	-11.25
8	15.25	-11.25	19	-13.85	11.25	8	15.25	11.25	19	-13.85	-11.25
9	16.75	-6.55	20	-16.75	11.25	9	16.75	6.55	20	-16.75	-11.25
10	16.75	-4.05	21	-16.75	3.25	10	16.75	4.05	21	-16.75	-3.25
11	16.75	4.05	22	-16.75	-3.25	11	16.75	-4.05	22	-16.75	3.25

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code

a = Pb-Free Package

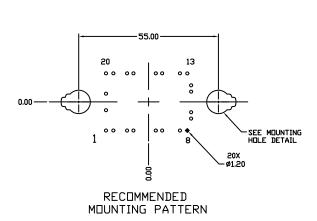
AT = Assembly & Test Site Code

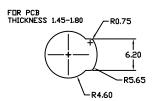
YYWW = Year and Work Week Code

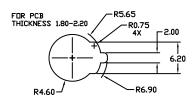
*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

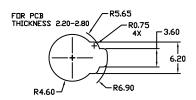
DOCUMENT NUMBER:	98AON63481G	Electronic versions are uncontrolled except when accessed directly from the Document Re Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.			
DESCRIPTION:	PIM22 55X32.5 / Q0BOOST	(SOLDER PIN)	PAGE 1 OF 2		

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MOUNTING HOLE DETAIL

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DESCRIPTION:	PIM22 55X32.5 / Q0BOOST	(SOLDER PIN)	PAGE 2 OF 2	

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